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Substitute for form 1449%/PTO (modified)

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Page 1 of 2 MAN 17 2002

Application Number	0/076003
Filing Date	February 14, 2002
First Named Inventor	Baude, Paul F.
Art Unit	2812
Examiner Name	
Attorney Case Number	57181US002

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Exa		Cite	Cite Document Number	Publication Date or Issue Date	Name of Patentee	Pages, Columns, Lines, Where Relevant Passages or Relevant			
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Exam Init.*	. Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published						
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Substitute for form 1449A/PTO (modifi	Application Number	10/076003
"	Filing Date	February 14, 2002
INFORMATION DISCLOSURE	First Named Inventor	Baude, Paul F.
STATEMENT BY APPLICANT	Art Unit	2812
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Page 2 of 2	Attorney Case Number	57181US002

		OTHER PRIOR ART NON PATENT LITERATURE DOCUMENTS
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C5		Gouy et al., "Deposition of Organic Semiconductor Through Silicon Shadow Masks for Integrated Led on Silicon."
C6		Kim et al., "Photoplastic Shadow-Masks for Rapid Resistless Multi-Layer Micropatterning".
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*Examiner:

Date Considered:

EXAMINER: Initial irreference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Page 1 of 1

Application Number	2076003
Filing Date	February 14, 2002
First Named Inventor	Baude, Paul F.
Art Unit	2812
Examiner Name	Unknown
Attorney Case Number	57181US002

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						ing Date	February 14, 2002		
						First Named Inventor		Baude, Paul F.	
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	А3	US-				
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